

Search Notes

Application/Control No.

09/809,030

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

BEN-ITZHAK, YUVAL

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
726	22-25	7/12/2007	S.C.
713	152,165	3/8/2007	S.C.
713	187-189	3/8/2007	S.C.
709	223-229	3/8/2007	S.C.

INTERFERENCE SEARCHED

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726	22-25	7/12/2007	S.C.
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713	187-189	3/8/2007	S.C.
709/223-229		3/8/2007	S.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	7/12/2007	S.C.
Consulted with primary examiner Chris Revak	7/12/2007	S.C.